Application/Control No.	Applicant(s)/Patent under Reexamination	
10/784,999	IDO ET AL.	
Examiner	Art Unit	
Denise Tran	2185	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class Subclass	Date	Examiner			
search history	4/14/2006	DT			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
·	DATE	EXMR	
East (USPGPUB;USPAT;USOCR;EPOAB; JPOAB;DERWENT;'IBMTDB)	4/14/2006	DT	
711/4, ,112,114,161-162; 707/202,204 ;709/203;714/6 (text search only, see search history)	4/14/2006	DT	
Inventor Name search (Palm and East)	4/14/2006	DT	
interference search (text search only, search history)	4/14/2006	DT	
IEEE .	4/14/2006	DT	